

## U.S. UTILITY Patent Application

PATENT	NL	JMB	ER	and
ISS	UE	DA	TΕ	

APPL NUM	FILING DATE	CLASS	SUBCLASS	GAUL		EXAMINER	
10007384	10/22/2001	<del>-438</del> -1	409	2812		TAN TRAN	
**APPLICANT	S: Nishibe	Eiji; Kiku	chi Shuichi;				
11	PPLICATIONS VE -372228 12/07/200		yes 171				
PG-PUB DO N	OT PUBLISH		RESCIN				
Foreign priority clai 35 USC 119 condit			o □ no		ATTO	ORNEY DOCKET NO	
16	wledged Examiners's in	•	13		1041	7-103001	
TITLE : Semico	nductor device and	manufa	cturing method	thereof	U.S.D	EPT. OF COMM./PAT.& TM-PTQ-436L	(Rev. 12-94)

NOTICE OF ALLOWANCE MAILED			CLAIMS ALLOWED				
		Assistant Examiner	Total Claims		Print Claim for O.G		
ISSUE FEE			DRAWING				
Amount Due	Date Paid	1	Sheets Drwg.	Figs.Drwg.	Print Fig.		
		Primary Examiner		L			
TERMINAL		PREPARED FOR ISSUE Application Examiner					
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